Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/686,095	PARK ET AL.
Examiner	**Art Unit**
Sam K. Ahn	2611

SEARCHED

Class	Subclass	Date	Examiner
375	130, 131, 132, 135, 137, 136, 261	12/11	
370	319, 344, 346		
455	464, 450, 457, 452.1		
341	57		
342	13, 14, 15, 16, 17, 18, 30, 42, 51	12/14	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST inventor search keyword & citation search IEEE & Google keyword, citation search consulted Khanh Tran 375 P.E.	12/11 12/14	